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NEW UTILITY PATENT APPLICATION TRANSMITTAL

(Large Entity)

(Only for new nonprovisional applications under 37 CFR 1.53(b))

Docket No.
EN997043

Total Pages in this Submission
3

TO THE ASSISTANT COMMISSIONER FOR PATENTS

Box Patent Application
Washington, D.C. 20231

Transmitted herewith for filing under 35 U.S.C. 111(a) and 37 C.F.R. 1.53(b) is a new utility patent application for an invention entitled:

Concentric Alignment Device For Dies And Die Stripper

and invented by:

E. F. Helinski

jc518 U.S. PTO
09/113712
07/10/98

If a **CONTINUATION APPLICATION**, check appropriate box and supply the requisite information:

☐ Continuation ☐ Divisional ☐ Continuation-in-part (CIP) of prior application No.: _____

Enclosed are:

Application Elements

1. ☒ Filing fee as calculated and transmitted as described below
2. ☒ Specification having 25 pages and including the following:
 - a. ☒ Descriptive Title of the Invention
 - b. ☐ Cross References to Related Applications (if applicable)
 - c. ☐ Statement Regarding Federally-sponsored Research/Development (if applicable)
 - d. ☐ Reference to Microfiche Appendix (if applicable)
 - e. ☒ Background of the Invention
 - f. ☒ Brief Summary of the Invention
 - g. ☒ Brief Description of the Drawings (if drawings filed)
 - h. ☒ Detailed Description
 - i. ☒ Claim(s) as Classified Below
 - j. ☒ Abstract of the Disclosure
3. ☒ Drawing(s) (when necessary as prescribed by 35 USC 113)
 - a. ☐ Formal
 - b. ☐ Informal

Number of Sheets 2

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Application Elements (Continued)

4. ☒ Oath or Declaration
- a. ☒ Newly executed (*original or copy*) ☐ Unexecuted
- b. ☐ Copy from a prior application (37 CFR 1.63(d)) (*for continuation/divisional application only*)
- c. ☒ With Power of Attorney ☐ Without Power of Attorney
5. ☐ Incorporation By Reference (*usable if Box 4b is checked*)
The entire disclosure of the prior application, from which a copy of the oath or declaration is supplied under Box 4b, is considered as being part of the disclosure of the accompanying application and is hereby incorporated by reference therein.
6. ☐ Computer Program in Microfiche (*Appendix*)
7. ☐ Nucleotide and/or Amino Acid Sequence Submission (*if applicable, all must be included*)
- a. ☐ Paper Copy
- b. ☐ Computer Readable Copy (*identical to computer copy*)
- c. ☐ Statement Verifying Identical Paper and Computer Readable Copy

Accompanying Application Parts

8. ☒ Assignment Papers (*cover sheet & document(s)*)
9. ☐ 37 CFR 3.73(B) Statement (*when there is an assignee*)
10. ☐ English Translation Document (*if applicable*)
11. ☒ Information Disclosure Statement/PTO-1449 ☒ Copies of IDS Citations
12. ☐ Preliminary Amendment
13. ☐ Acknowledgment postcard
14. ☒ Certificate of Mailing
- ☐ First Class ☒ Express Mail (*Specify Label No.*): EM589153613
15. ☐ Certified Copy of Priority Document(s) (*if foreign priority is claimed*)

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Accompanying Application Parts (Continued)

16. ☐ Additional Enclosures (please identify below):

Fee Calculation and Transmittal

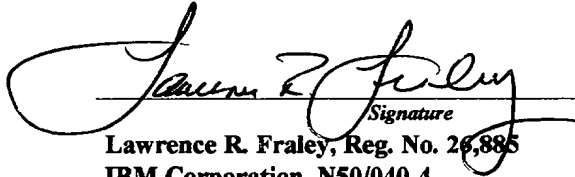
CLAIMS AS FILED

For	#Filed	#Allowed	#Extra	Rate	Fee
Total Claims	20	- 20 =	0	x \$22.00	\$0.00
Indep. Claims	3	- 3 =	0	x \$82.00	\$0.00
Multiple Dependent Claims (check if applicable) <input type="checkbox"/>					\$0.00
BASIC FEE					\$790.00
OTHER FEE (specify purpose)					\$0.00
TOTAL FILING FEE					\$790.00

- ☐ A check in the amount of _____ to cover the filing fee is enclosed.
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 - ☐ Charge the issue fee set in 37 C.F.R. 1.18 at the mailing of the Notice of Allowance, pursuant to 37 C.F.R. 1.311(b).

Dated:

July 10, 1998


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CC: Records

CONCENTRIC ALIGNMENT DEVICE FOR DIES AND DIE STRIPPER

Edward F. Helinski

FIELD OF THE INVENTION

5 The present invention relates to devices for forming
holes in substrates. In particular, the present invention
relates to a device for mechanically punching holes in
substrates. The present invention is particularly useful
for punching holes in thin films for use in the electronics
industry. More particularly, the present invention relates
10 to a device for aligning punches in dies for mechanically
forming holes in substrates.

BACKGROUND OF THE INVENTION

15 Some aspects of the fabrication of structures for use
in the electronics industry require the formation of holes
in a substrate. Often, the holes punched in the substrate
are quite small. Additionally, typically the holes must be
very accurately located. These factors also subject the
apparatus utilized to form the holes to similar tolerance
and alignment standards.

SUMMARY OF THE PRESENT INVENTION

Aspects of the present invention provide a punch and die alignment system. The system includes a first die including a first die aperture for receiving at least a portion of a punch. The system also includes a second die including a second die aperture for receiving at least a portion of the punch. A first housing includes a first die passage for receiving at least a portion of the first die. A second housing includes a second die passage for receiving at least a portion of the second die and at least a portion of the first die. The second die passage permits at least a portion of the first die to rotate therein. Thereby permitting the first die aperture and the second die aperture to be aligned with each other.

Other aspects of the present invention provide a method of aligning dies of a punch and die assembly. The method includes inserting at least a portion of a punch into a punch receiving passage or first die aperture in a first die. The punch receiving passage of the first die is aligned with a punch receiving passage of a second die by rotating the first die with respect to the second die and attempting to advance the punch into the punch receiving passage in the second die to determine a location of the

first die relative to the second die where the punch will experience a least amount of frictional forces from walls of the punch receiving aperture of the first die and the punch receiving aperture of the second die when being advanced
5 through the punch receiving aperture of the first die and the punch receiving aperture of the second die.

Additional aspects of the present invention provide a punch and die assembly. The punch and die assembly includes a first die including a first die aperture for receiving at
10 least a portion of a punch. The second die includes a second die aperture for receiving at least a portion of the punch. A first housing includes a first die passage for receiving at least a portion of the first die. A second housing includes a second die passage for receiving at least
15 a portion of the second die and at least a portion of the first die. The second die passage permits at least the first die to rotate therein, thereby permitting the first die aperture and second die aperture to be aligned with each other. The punch and die assembly also includes a punch
20 assembly including a punch, at least a portion of which extends through the first die aperture and second die aperture during a punching operation.

Still other objects and advantages of the present

invention will become readily apparent by those skilled in the art from the following detailed description, wherein it is shown and described only the preferred embodiments of the invention, simply by way of illustration of the best mode contemplated of carrying out the invention. As will be realized, the invention is capable of other and different embodiments, and its several details are capable of modifications in various obvious respects, without departing from the invention. Accordingly, the drawings and description are to be regarded as illustrative in nature and not as restrictive.

BRIEF DESCRIPTION OF THE FIGURES

The above-mentioned objects and advantages of the present invention will be more clearly understood when considered in conjunction with the accompanying drawings, in which:

Fig. 1 represents a cross-sectional view of an embodiment of a known single punch and die assembly; and

Fig. 2 represents a cross-sectional view of an embodiment of a punch and die assembly according to the present invention.

DETAILED DESCRIPTION OF THE INVENTION

As discussed above, the present invention relates to mechanically punching holes in substrates. The present invention is particularly useful for insuring that punches and dies are precisely aligned. Helping to insure that punches and dies are aligned as good as possible helps to ensure a better fit in die bar assemblies. The present invention may also result in higher hole quality and longer punch and die life.

Fig. 1 illustrates an embodiment of a known single punch and die assembly. The device illustrated in Fig. 1 includes a punch 1. The punch includes a punch stem 2 and a punch tip 3. The punch 1 may be biased in a retracted position by compression spring 5. All of the elements of the punch, including actuation means, may be referred to as a punch assembly 7.

Punch tip 3 extends into an upper die 9, sometimes called a material stripping die or stripper. Upper die 9 includes a punch receiving passage 17. The upper die 9, the punch, compression spring 5, and other portions of the punch assembly are typically housed within upper housing 11.

5 The punch and die assembly shown in Fig. 1 also includes a lower housing 13. A lower die 15, sometimes called a cutting die, is housed within housing 13. The lower or cutting die 15 typically includes a cutting surface 20 about the upper opening of the punch receiving passage 19. Lower die 15 includes a punch receiving passage 19.

10 For a punching operation, the upper housing 11 and lower housing 13 are placed in close proximity to each other. A substrate 21 in which holes to be formed is arranged between the upper housing 11 and the upper die 9 and the lower housing 13 and lower die 15.

15 When forming a hole in the substrate 21, the punch tip 3 passes through punch receiving passage 17 in the upper die 9, through substrate 21 and into punch receiving passage 19 in the lower die 15. Typically, punches such as that shown in Figs. 1 and 2 are actuated by a driving coil assembly. The punches are directly propelled by electromagnetic repulsion forces generated between the coil and the copper disc at the rear of the punch. Leads leading away from the 20 coil connect the coil to a driver circuit.

To actuate the punch, the driver circuit sends a current pulse down the leads to the coil. The current pulse

in the coil generates a rapidly changing magnetic field. This field in turn generates intense eddy currents in the copper disc. The coil magnetic field interacting with the secondary magnetic field generated by the eddy currents
5 repels the punch, propelling it toward the dies and the substrate in which holes are to be formed.

Preferably, the punch is propelled with an extremely high accelerating force. According to one embodiment, the accelerating force on the punch is approximately 20 lbs.
10 However, the force of the punch may be varied, depending, among other factors, upon the substrate being punched, for example.

As stated above, and as illustrated in Figs. 1 and 2, the punch assembly may also include a spring for biasing the punch in an unextended direction, in other words, in a
15 retracted position. The spring returns the punch to its starting position after actuation. The force that the spring applies to the punch may be varied, depending upon the application.

20 During actuation, the driving coil will be energized, producing a magnetic field that repels the punch. The magnetic field causes the punch to travel through the dies.

After exiting the upper die, the punch then engages the substrate to form a hole.

After engaging the substrate, the punch applies pressure to the upper surface of the substrate. The pressure applied to the substrate forces it onto the lower die. The cutting surface of the lower die will cut the substrate as the pressure from the punch in the opening of the lower die increases. When the substrate is finally cut and a hole formed therein, the punch will pass into the punch receiving aperture of the lower die. Upon reaching its maximum extension, the punch will then be drawn back to its starting position by the return spring and the rebound momentum derived from the bounce of the punch off of the top of the punch guide.

Often, punches and dies have extremely small clearances and tolerances. Additionally, some of these tolerances may be too small to be accurately measured utilizing currently known technology. For example, according to some applications, the clearance between punch tip 3 and punch receiving openings 17 in the upper die 9 must be fitted to a clearance of about 0 to about 10 millionths of an inch. The lower die may also have a similar clearance with respect to the punch tip.

5 A clearance of about 10 millionths of an inch makes it
necessary for the punch tip and punch receiving passages to
have a concentricity of about 5 millionths of an inch or
less relative to the outside diameter of the punch tip. If
this clearance is not achieved, edges of the punch may
interfere with the cutting dies. Initially, interaction
between the punch and dies may result in undesirable forces
on the punch and/or dies. Interaction between the punch tip
and the cutting dies may cause chipping of the punch and/or
10 dies. In some instances, portions of the substrate could be
pinched between the punch and die resulting in damage, such
as deformation or material removal, from the substrate being
punched. Substrate material may also be more likely to
interfere with movement of the punch and clog the punch
15 receiving opening in the dies.

The present invention provides an apparatus and method
for aligning dies and a punch that passes through the dies
to form holes in a substrate arranged between the dies.
Fig. 2 illustrates an example of an embodiment of a punch
20 assembly according to the present invention. The embodiment
illustrated in Fig. 2 includes punch 27. Punch 27 includes
punch stem 36 and punch tip 24. Compression spring 37
biases the punch 27 in a retracted position. The elements
including the punch, the compression spring, and other

components added to the punch may be referred to and assembled into punch assembly 38.

The punch/punch assembly may be at least partially housed within an upper housing 32. Upper housing 32 may include a passage 23 for receiving the punch stem 36. The upper housing 32 may also include a die receiving passage 35. Die receiving passage 35 receives at least a portion of upper die 25. Typically, to permit upper die 25 or a member attached upper die 25 to rotate, the die receiving passage 34 typically has a cylindrical cross-section in a horizontal plane perpendicular to the plane of the cross-section illustrated in Fig. 2.

It follows that upper die 25 may also have a cylindrical cross-section in a horizontal plane perpendicular to the cross sectional plane illustrated in Fig. 2. Alternatively, upper die 25 could be interconnected with a member having a cylindrical cross-section. The cylindrical cross-section of upper die 25 or an attached member permits upper die 25 to rotate within die receiving passage 34 in lower housing 33.

Upper die 25 may have a U-shaped cross-section when viewed in the plane illustrated in Fig. 2. However, the

upper die may have other cross-sectional shapes. For example, the entire die could be solid rather than having a U-shape. Nonetheless, the shape of the upper die illustrated in Fig. 2 may maximize the stability of upper die 25 within the die receiving passage 35 while minimizing the distance over which the punch tip must pass through a die receiving aperture in the die or receiving the punch.

Upper die 25 includes a punch receiving aperture 40 for receiving at least a portion of the punch tip 24. The edge 42 of upper die 25 may be beveled as illustrated in Fig. 2 to facilitate insertion of upper die 25 in a die receiving passage.

The present invention may also include a lower housing 33. Lower housing 33 includes a die receiving passage 34 for receiving lower die 26. As with upper die receiving passage 35, die receiving passage 34 in the lower housing 33 typically has a cylindrical cross-section in a horizontal plane perpendicular to the cross-sectional plane illustrated in Fig. 2. Alternatively, the lower die may be interconnected with another member having a cylindrical cross-section. The cylindrical cross-sectional shape of die receiving passage 34 may facilitate rotation of upper die 25 and/or lower die 26 if arranged within die receiving passage

34.

5 The present invention includes lower die 26. The lower die may have a substantially similar shape as the upper die. Therefore, the above discussion regarding the shape and configuration of the upper die is referred to and applies here with respect to the lower die as well. For example, the lower die may have a substantially inverted U-shape, as illustrated in Fig. 2. The edge 46 of the lower die may also be beveled. One difference between the upper die and the lower die is that lower die 26 may include cutting surface 48 around the perimeter of the punch receiving passage. Cutting surface 48 helps to facilitate the formation of holes in a substrate arranged between upper die and lower die.

15 By permitting rotation of at least one of the upper die and the lower die relative to the other, the present invention may permit the upper die aperture and the lower die aperture to be arranged relative to each other as optimally close as concentricity permitted by the dies and the upper housing and the lower housing. The present invention may permit the upper die aperture and lower die aperture to be aligned so as to be concentric with in about 20 5 millionths of an inch. However, any necessary alignment

alignment may be created with the present invention.
According to a typical embodiment, the best possible or
optimal alignment is created with the present invention.

5 Once aligned, an alignment mark may be created or
applied or otherwise provided on the first die and on the
second die. The alignment of a particular upper die and
lower die may be recreated in a particular upper housing and
lower housing by simply realigning the alignment marks on
the upper die and lower die. The present invention permits
10 pairs of matched dies to be properly aligned when mounted in
a die bar assembly. The present invention may permit a
delicate and precise alignment that may not be achievable
with known measurement and/or alignment methods and/or
apparatuses.

15 When aligning dies according to the present invention,
a first die and/or a second die maybe selected and matched
to die receiving passages in an upper and lower housing,
respectively. According to one embodiment, the dies may be
matched to die receiving passages in upper and lower
20 housings so as to have a space between the outer surface of
the die and the inner surface of the die receiving passage
between about 0 and about 10 millionths of an inch. Then,
at least a portion of the upper die or the lower die may be

inserted into their respective opening in either the upper housing or the lower housing. According to one embodiment, rather than being aligned in an upper housing and a lower housing, the dies may be aligned in an alignment apparatus that includes two members similar to the upper housing and the lower housing. Alternatively, the upper housing and the lower housing may be arranged together as they would be in a complete punch assembly for alignment. The alignment may then be carried and then the dies and housings transferred to the punch assembly.

To align the dies of a punch and die assembly, at least a portion of the punch, such as at least a portion of the punch tip, may be inserted into the punch receiving aperture in one of the dies. The dies may then be arranged with respect to each other as they would be arranged in the working punch and die assembly. For example, prior to alignment, the entire punch assembly and the housings may be assembled. Also prior to alignment, the upper die may be inserted into the die receiving passage in the lower housing and/or the lower die may be inserted in the die receiving passage of the upper housing to ensure proper fit of the dies in those passages as well.

Next, the dies may be arranged relative to each other

by rotating at least one of the dies with respect to the other while attempting to advance the punch into the punch receiving passage in the second die to determine a location of a first die relative to the second die where the punch will experience the least amount of frictional or interference forces from walls of the punch receiving apertures of the first die and the second die. The alignment of the dies may be such that the punch may actually hit an area of the one of the dies in the vicinity of the opening of the punch receiving passages and be entirely prevented from advancing through the punch receiving passages or apertures. Once the desired arrangement of the two dies with respect to each other is determined, the relative positions of the first die and second die may be recorded by providing at least one mark on the first die and the second die.

Prior to alignment, at least a portion of the lower die may be inserted into the die receiving passage in lower housing. Similarly, at least a portion of the upper die may be inserted into the die receiving passage 35 in the upper housing 32. In the embodiment illustrated in Fig. 2, the lower die may be entirely inserted into the lower die receiving passage 34 in the lower housing 33. In this embodiment, the upper die 25 may be only partially inserted

into the die receiving passage 35 in the upper housing 32.
The remaining portion of the upper die 25 may be inserted
into the die receiving passage 34 in the lower housing. In
this embodiment, the upper housing and/or the lower housing
and/or upper die and/or lower die may be free for rotation
5 relative to each another.

After preliminarily arranging the upper die, lower die,
upper housing and/or lower housing, the punch may be at
least partially inserted into the punch receiving aperture
10 40 in the upper die 25. The upper die may need to be
rotated to ensure free passage of the punch into the punch
receiving aperture 40. Then, the upper die 25, lower die
26, upper housing, and/or lower housing may be rotated while
the punch is attempted to be depressed repeatedly until the
15 most concentric alignment between the punch receiving
aperture 40 and punch receiving aperture 50 is achieved. In
the process according to the present invention, the punch
may first be at least partially inserted into what is
referred to herein as the lower die. In such an embodiment,
20 the above process may still be followed, but references to
upper and lower reversed.

After alignment, the position of the upper die and the
lower die with respect to each other are then marked on the

upper and lower dies. The marking could include any
suitable marking. For example, the marking could include a
mark formed with a writing instrument. Other markings could
include something adhesively adhered to the upper die and
5 the lower die. Other satisfactory marking methods may also
or alternatively be employed.

The present invention may include a sensor for sensing
frictional resistance between the punch and the punch
receiving apertures in the upper and lower die during the
10 alignment process. Such an embodiment may include some
means of display for indicating the interference forces or
frictional forces.

Utilizing the present invention, about 40 die and punch
sets have been matched for rotation alignment. About 70
15 percent of the matched die and punch sets have a
significantly better fit as compared to alignment without
utilizing the present invention. Of the 40, about 25
percent seemed to fit well in any rotational condition and
about 5 percent did not fit well regardless of rotation or
20 alignment. Thus, about 5 percent could be eliminated from
final assemblies. Clearly, the present invention
significantly improves the alignment condition of punches
and dies as showing a better fitting die bar assembly in

resulting in higher and punch and die life.

The foregoing description of the invention illustrates and describes the present invention. Additionally, the disclosure shows and describes only the preferred
5 embodiments of the invention, but as aforementioned, it is to be understood that the invention is capable of use in various other combinations, modifications, and environments and is capable of changes or modifications within the scope of the inventive concept as expressed herein, commensurate
10 with the above teachings, and/or the skill or knowledge of the relevant art. The embodiments described hereinabove are further intended to explain best modes known of practicing the invention and to enable others skilled in the art to utilize the invention in such, or other, embodiments and
15 with the various modifications required by the particular applications or uses of the invention. Accordingly, the description is not intended to limit the invention to the form disclosed herein. Also, it is intended that the appended claims be construed to include alternative
20 embodiments.

CLAIMS

I claim:

1 1. A punch and die alignment system, comprising:
2 a first die including a first die aperture for
3 receiving a punch;
4 a second die including a second die aperture for
5 receiving the punch;
6 a first housing including a first die passage for
7 receiving at least a portion of the first die; and
8 a second housing including a second die passage for
9 receiving at least a portion of at least one of the first
10 die and the second die and permitting at least one of the
11 first die and the second die to rotate therein, thereby
12 permitting the first die aperture and the second die
13 aperture to be aligned with each other.

1 2. The punch and die alignment system according to
2 claim 1, wherein the second die passage receives at least a
3 portion of the second die and at least a portion of the
4 first die.

1 3. The punch and die alignment system according to
2 claim 1, wherein the second die passage permits at least the

3 first die to rotate therein.

1 4. The punch and die alignment system according to
2 claim 1, further comprising:

3 a first alignment mark on the first die; and

4 a second alignment mark on the second die;

5 wherein alignment of the first alignment mark and the
6 second alignment mark aligns the first die aperture and the
7 second die aperture.

1 5. The punch and die alignment system according to
2 claim 1, wherein the first die aperture and the second die
3 aperture may be aligned to be concentric within about 5
4 millionths of an inch.

1 6. A punch and die assembly, comprising:

2 a first die including a first die aperture for
3 receiving a punch;

4 a second die including a second die aperture for
5 receiving the punch;

6 a first housing including a first die passage for
7 receiving at least a portion of the first die;

8 a second housing including a second die passage for
9 receiving at least a portion of the second die and at least
10 a portion of the first die and permitting at least one of

11 the first die and the second die to rotate therein, thereby
12 permitting the first die aperture and the second die
13 aperture to be aligned with each other; and

14 a punch assembly including a punch extending through
15 the first die aperture and the second die aperture during a
16 punching operation.

1 7. The punch and die alignment system according to
2 claim 6, wherein the second die passage receives at least a
3 portion of the second die and at least a portion of the
4 first die.

1 8. The punch and die alignment system according to
2 claim 6, wherein the second die passage permits at least the
3 first die to rotate therein.

1 9. The punch and die assembly according to claim 6,
2 further comprising:

3 a first alignment mark on the first die; and

4 a second alignment mark on the second die;

5 wherein alignment of the first alignment mark and the
6 second alignment mark aligns the first die aperture and the
7 second die aperture.

1 10. The punch and die assembly according to claim 6,

2 wherein the first die aperture and the second die aperture
3 may be aligned to be concentric within about 5 millionths of
4 an inch.

1 11. The punch and die assembly according to claim 6,
2 further comprising:

3 a compression spring for biasing the punch in a
4 retracted position.

1 12. A method of aligning dies of a punch die assembly,
2 the method comprising the steps of:

3 inserting a punch into a punch receiving passage a
4 first die; and

5 aligning the punch receiving passage of the first die
6 with a punch receiving passage of a second die by rotating
7 the first die with respect to the second die and attempting
8 to advance the punch into the punch receiving passage in the
9 second die to determine a location of the first die relative
10 to the second die where the punch will experience a least
11 amount of frictional forces from walls of the punch
12 receiving aperture of the first die and the punch receiving
13 aperture of the second die.

1 13. The method according to claim 12, further
2 comprising the step of:

3 recording the relative positions of the first die and
4 the second die after alignment of the first punch receiving
5 passage and the second punch receiving passage by providing
6 a mark on the first die and the second die.

1 14. The method according to claim 12, further
2 comprising the steps of:

3 inserting the second die into a die receiving passage
4 in a first housing; and

5 inserting at least a portion of the first die into the
6 die receiving passage in the first housing.

1 15. The method according to claim 12, further
2 comprising the step of:

3 selecting the first die and the second die for
4 rotational alignment prior to aligning the first punch
5 receiving passage and the second punch receiving passage.

1 16. The method according to claim 14, further
2 comprising the step of:

3 selecting the first housing such that the first die
4 will snugly fit into the die receiving passage.

1 17. The method according to claim 16, wherein the
2 first housing is selected such that the first die and the

3 die receiving passage in the first housing are concentric to
4 within less than 10 millionths of an inch.

1 18. The method according to claim 12, wherein the
2 first punch receiving passage and the second punch receiving
3 passage are aligned to be concentric to within about 5
4 millionths of an inch.

1 19. The method according to claim 14, further
2 comprising the steps of:
3 arranging a second housing on the first die; and
4 arranging a punch assembly onto the second housing,
5 inserting a punch into a punch receiving passage in the
6 first die.

1 20. The method according to claim 19, further
2 comprising the step of:
3 arranging a compression spring on the punch to bias the
4 punch in a retracted position after arranging the punch
5 assembly on the second housing.

CONCENTRIC ALIGNMENT DEVICE FOR DIES AND DIE STRIPPER

ABSTRACT OF THE DISCLOSURE

A punch and die alignment system. A first die includes a first die aperture for receiving a punch. A second die includes a second die aperture for receiving the punch. A first housing includes a first die passage for receiving at least a portion of the first die. A second housing includes a second die passage for receiving at least a portion of at least one of the second die and the first die and for permitting at least one of the first die and the second die to rotate therein, thereby permitting the first die aperture and the second die aperture to be aligned with each other.

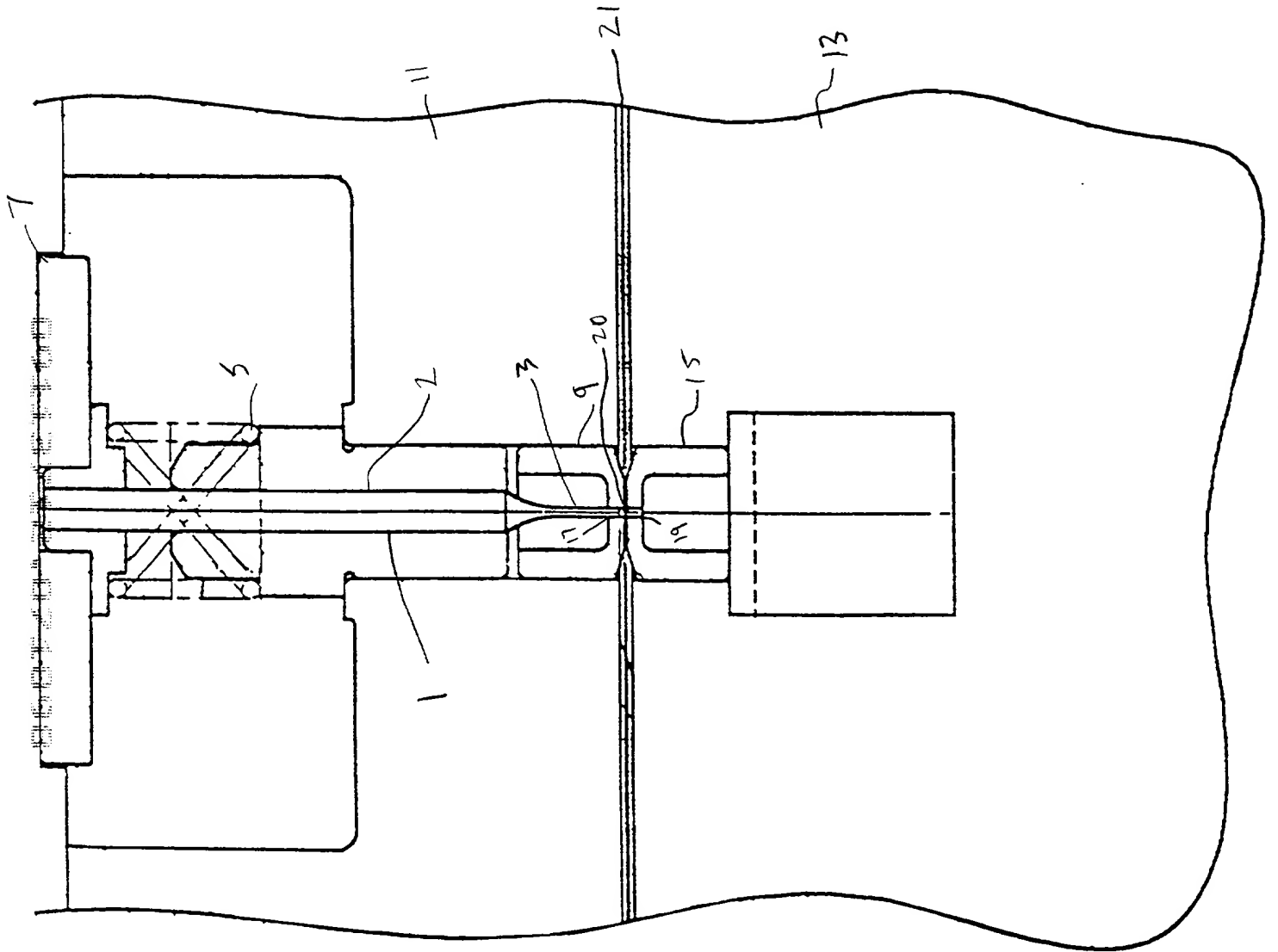


Fig. 1

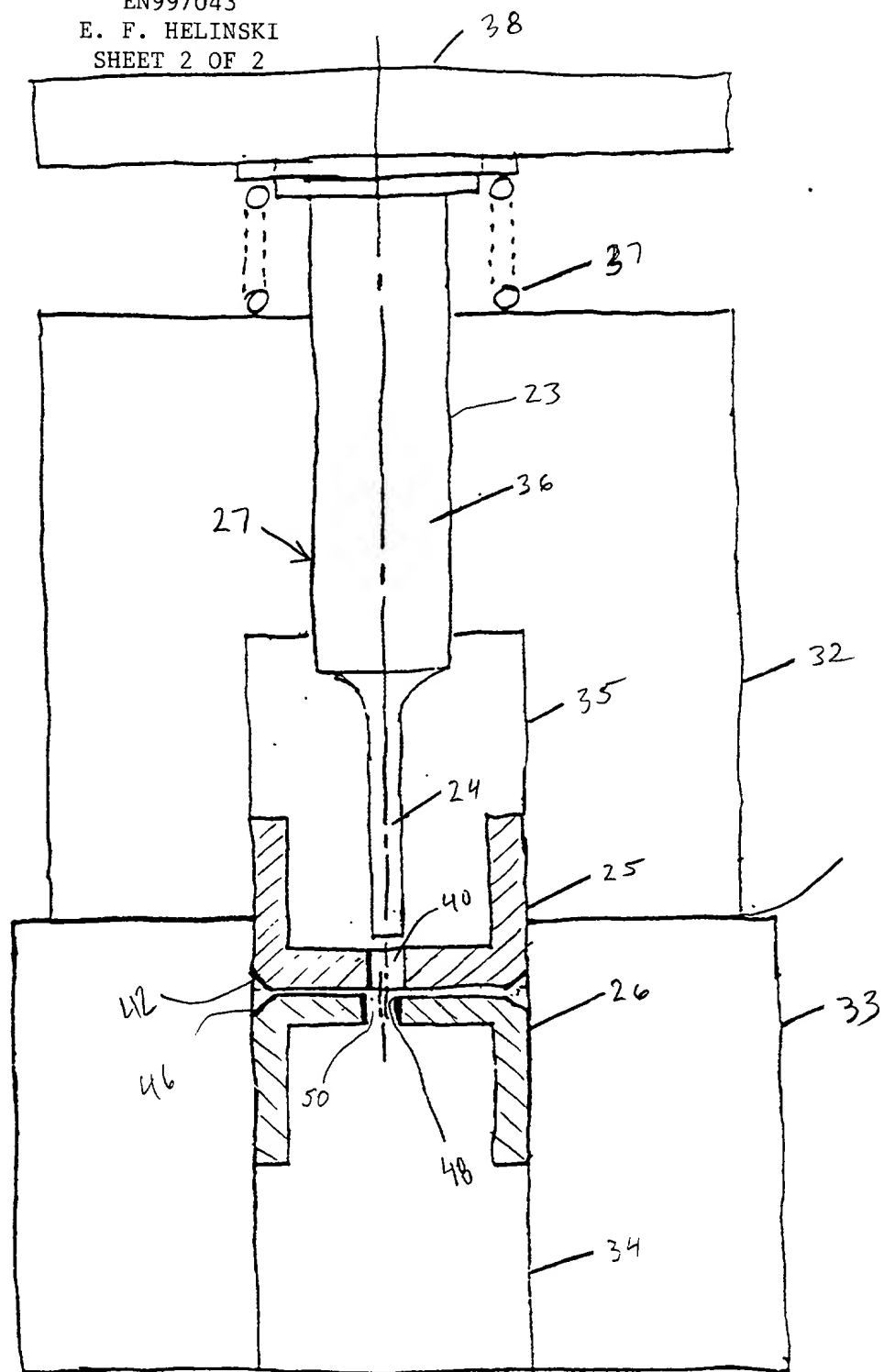


FIGURE 2

DECLARATION FOR PATENT APPLICATION

EN997-043

As a below-named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled: CONCENTRIC ALIGNMENT DEVICE FOR DIES AND DIE STRIPPER
the specification of which. (check one)

☒ is attached hereto ☐ was filed on , as United States Patent Application Serial No. or PCT International Application Number , and was amended on (if applicable).

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment referred to above

I acknowledge the duty to disclose information which is material to the patentability of this application in accordance with 37 CFR § 1.56(a).

Prior Foreign Application(s): I hereby claim foreign priority benefits under 35 U.S.C. § 119(a)-(d) or §365(b) of any foreign application(s) for patent or inventor's certificate listed below, or § 365(a) of any PCT international application which designated at least one country other than the United States of America, listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

Priority Claimed

(Application No.)	(Country)	(Day/Month/Year Filed)	<input type="checkbox"/> Yes <input type="checkbox"/> No
(Application No.)	(Country)	(Day/Month/Year Filed)	<input type="checkbox"/> Yes <input type="checkbox"/> No
(Application No.)	(Country)	(Day/Month/Year Filed)	<input type="checkbox"/> Yes <input type="checkbox"/> No

I hereby claim the benefit under Title 35, United States Code § 119(e) of any United States provisional application(s) listed below:

Application No.

Filing Date

I hereby claim the benefit under 35 U.S.C. § 120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by 35 U.S.C. § 112, first paragraph, I acknowledge the duty to disclose material information as defined in 37 CFR § 1.56(a) which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

(U.S. Application Serial No.)	(U.S. Filing Date)	(Status--patented, pending, abandoned)
(U.S. Application Serial No.)	(U.S. Filing Date)	(Status--patented, pending, abandoned)

I hereby appoint the following attorneys and/or agents to prosecute this application and transact all business in the Patent and Trademark Office connected therewith: David L. Adour, Reg. No. 29,604, Lawrence R. Fraley, Reg. No. 26,885, Arthur J. Samodovitz, Reg. No. 31,297, Bernard Tiegerman, Reg. No. 29,707, all of INTERNATIONAL BUSINESS MACHINES CORPORATION; Elliott I. Pollock, Reg. No. 16,906, George Vande Sande, Reg. No. 17,276, Robert R. Priddy, Reg. No. 20,169, Burton A. Amernick, Reg. No. 24,852, Stanley B. Green, Reg. No. 24,351, Richard Wiener, Reg. No. 18,741, Townsend M. Belser, Jr., Reg. No. 22,956; Morris Liss, Reg. No. 24,510, Martin Abramson, Reg. No. 25,787, George R. Pettit, Reg. No. 27,369, Elzbieta Chlopecka, Reg. No. 32,767, Eric J. Franklin, Reg. No. 37,134, and Jeffri A. Kaminski, Reg. No. P-42,709; all of POLLOCK, VANDE SANDE & PRIDDY; John E. Hoel, Reg. No. 26,279, Christopher A. Hughes, Reg. No. 26,914, Edward A. Pennington, Reg. No. 32,588; Joseph C. Redmond, Jr., Reg. No. 18,753; all of MORGAN & FINNEGAN, L.L.P.

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I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true, and further that these statements are made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under 18 U.S.C. § 1001 and that such willful false statements may jeopardize the validity of the application or any patent issued thereon

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